Search Notes (continued)

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/677,097	LEE ET AL.	
Examiner	**Art Unit**	
SUSAN HANLEY	1651	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inter. search for SEQ ID Nos 1,2,6,7 in interference DBs by STIC	5/25/2009	SMH